# Thin Film Multilayer Conductor/Ferroelectric Tunable Microwave Components for Communication Applications

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# THIN FILM MULTILAYER CONDUCTOR/FERROELECTRIC TUNABLE MICROWAVE COMPONENTS FOR COMMUNICATION APPLICATIONS

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A study of Au/SrTiO<sub>3</sub>/YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-8</sub>/LaAlO<sub>3</sub> and (Au,YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-8</sub>)/  $Ba_xSr_{1-x}TiO_3/LaAlO_3$  (x=0, 0.50, and 0.40) multilayered structures is presented. At 1.0 MHz, the largest tuning of Au/SrTiO<sub>3</sub>/YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-8</sub> parallel plate capacitors corresponded to single-phased, epitaxial 300-500 nm thick SrTiO<sub>3</sub> thin films deposited at 800 °C. For SrTiO<sub>3</sub>/LaAlO<sub>3</sub> structures having SrTiO<sub>3</sub> films of similar quality, we observed that at 1.0 MHz and 77 K, interdigital capacitors exhibit higher tunabilities and lower losses than parallel plate configurations, but required higher dc voltage. For a 300 nm thick SrTiO<sub>3</sub> film, a 25 ΩYBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-δ</sub>/SrTiO<sub>3</sub>/ LaAlO<sub>3</sub> phase shifter exhibited a phase shift ~2.6 times larger than its Au/SrTiO<sub>3</sub>/LaAlO<sub>3</sub> counterpart. At 19 GHz and 32 V, a 360° phase shift could in principle be achieved with coupled microstripline sections only 7.0 mm long. At 14 GHz, 77 K and 260 V, for 1.0 µm and 300 nm thick  $SrTiO_3$  films, 25  $\Omega$  360° Au/SrTiO<sub>3</sub>/LaAlO<sub>3</sub> phase shifters would be nominally 4.0 mm and 12 mm long, respectively. For a 2λ YBa<sub>2</sub>Cu<sub>3</sub> O<sub>7-8</sub> SrTiO<sub>3</sub>/LaAlO<sub>3</sub> ring resonator a tuning rate of 0.7 MHz/Volt was achieved at 10 GHz and 77 K. The relevance of these structures for phased array antennas and as tunable elements in discriminator-stabilized oscillators is discussed.

<u>Keywords:</u> (HTS,metal)/ferroelectric structures; tunable microwave components; dielectric constant; loss tangent; parallel plate and interdigital capacitors; phase shifters; ring resonators.

### **INTRODUCTION**

Improvements in the quality of ferroelectric thin films have prompted their usage in proof-of-concept (POC) tunable microwave components such as varactors, phase shifters, and filters, amongst others.<sup>[1-3]</sup> For practical microwave applications, issues such as optimization of the dielectric properties of the ferroelectric films, device configuration (i.e., parallel or interdigital), and degree of tunability versus losses, amongst others, must be addressed.

In the area of satellite communications, congestion of the frequency spectrum at and below the Ku-band resulting from the boom of the wireless communication industry, has prompted utilization of higher frequency bands such as the K- and Ka-band. Phased array antennas have been identified as a critical component for many of the proposed satellite constellations (e.g., Teledesic) targeted for operation by the turn of the century<sup>[4]</sup>. Hence, compact, low loss phase shifters will be an enabling component for these applications. In addition, small, low cost, low-phase noise local oscillators (LO) which are compatible with high order, bandwidth efficient modulation schemes (e.g., QPSK) are required.

In this paper, we report on our study of gold/SrTiO<sub>3</sub>/YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-δ</sub>/LaAlO<sub>3</sub>(Au/STO/YBCO/LAO) and (gold, YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-δ</sub>)/Ba<sub>x</sub>Sr<sub>1-x</sub>TiO<sub>3</sub>/LaAlO<sub>3</sub>(x=0, 0.50, and 0.40) ((Au,YBCO)/BSTO/LAO) multilayered structures. The effect of the deposition temperature of the ferroelectric film on the tuning and losses of parallel plate capacitors at 1.0 MHz is discussed. Dependence of tuning and losses on the geometry of the tunable components is presented. As a demonstration of the great potential of these components for advantageous insertion into satellite and ground-based communication systems, we present results of proof-of-concept (POC) coupled microstripline phase shifters (CMPS) and interdigital ring resonators for LO between the 10-20 GHz frequency range.

### **EXPERIMENTAL**

The multilayer structures considered in this study were deposited in-situ on (100) LAO single-crystal substrates (254 and 508 µm thick) by pulsed laser deposition (PLD). The dielectric properties of the STO films in the Au/STO/YBCO parallel plate configuration were studied by varying the deposition temperature of the ferroelectric film from 825° to 250 °C. For all these structures the YBCO films were deposited at 800 °C. For this part of the study, the STO films were 300-500 nm thick, and the YBCO films were ~350 nm thick. The parallel plate capacitor used in this study is similar to that used previously;<sup>[5,6]</sup> Au electrodes (~2.5 μm thick) were used. For the interdigital configurations we used Au and platinum (Pt) electrodes, 0.5 µm thick. In this configuration we also examined BSTO films which were also deposited by PLD and were ~500 nm thick. The electrodes were deposited by electron beam (e-beam) evaporation. A 15 nm thick titanium or chromium adhesion layer was e-beam evaporated before the metal deposition. Standard photolithography techniques and chemical etching (lift-off) were used to fabricate these structures. The crystal structure and surface topology of the ferroelectric films were analyzed by X-Ray Diffraction (XRD) and Atomic Force Microscopy (AFM), respectively.

At low frequencies (i.e., 1.0 MHz), the electrical response of the multilayer structures was studied by measuring the dielectric constant  $(\varepsilon_r)$ and loss tangent ( $tan\delta$ ) of the ferroelectric film as a function of temperature (300-20 K), at ac voltages within 5-100 mV, and at dc electric fields from zero to 1.0×10<sup>5</sup> V/cm for the parallel plate capacitors, and up to 3.5×10<sup>5</sup> V/cm for the interdigital configurations. An HP 4192A LF Impedance Analyzer coupled through bias lines to the second stage of a closed-cycle helium gas refrigerator was used to perform these measurements. The measurement system was fully automated and controlled by an HP 900-300 computer. Characterization of the coupled microstripline phase shifters and the interdigital ring resonators at frequencies between 10-20 GHz was performed using an HP 8510C automatic network analyzer (ANA) coupled through semi-rigid input/ output coaxial cables to the second stage of a closed-cycle helium gas refrigerator similar to the one mentioned above. All the measurements were performed under a vacuum of less than 10 mtorr.

### **RESULTS**

Figure 1 shows data on  $\varepsilon_r$  and  $\tan\delta$  for a Au/STO/YBCO parallel plate capacitor with the STO film deposited at 800 °C. The area for the Au electrodes was 400×400 µm<sup>2</sup> and the STO film was 300 nm thick. In this study we found that the largest tuning corresponds to the structures with the 800 °C STO films. As reported previously, we have observed that higher deposition temperatures resulted in interfacial degradation and poor film quality, while lower deposition temperatures resulted in films with lower dielectric constants, lower tunabilities, and higher losses.<sup>[7]</sup> Similar results were also obtained for film thicknesses near 500 nm. For STO films deposited at temperatures near 800 °C, XRD scans showed that the films were (100) oriented and singled-phased. Thus, maximum tuning of the Au/STO/YBCO structure can be attained with single-phased, epitaxial 300-500 nm thick STO films deposited at 800 °C. As shown in figure 1, the  $\tan\delta$  for these films was typically ~0.05 for temperatures below 80 K, and was insensitive to changes in dc bias. However, we have observed that the parallel plate structure is influenced by electrical shorts in the ferroelectric film which are in turn associated with the roughness of the YBCO film. [6,8] Thus, improving the smoothness of the underlying YBCO layer may help in reducing the electrical shorts in the ferroelectric layers.

The dielectric properties of the interdigital structures investigated were significantly different from those of the parallel plate capacitors. Several capacitor dimensions were studied; in general the gaps between the electrodes and the finger width were either 10 or 20  $\mu m$ , the number of

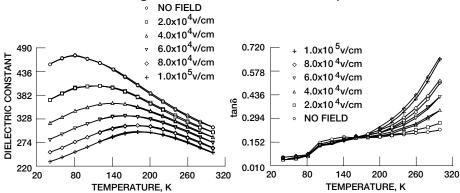


Figure 1 Dependence of  $\epsilon_r$  and  $\tan\delta$  on temperature and applied dc field for the STO film in a Au/STO/YBCO parallel plate capacitor. The STO film (300 nm) was deposited at 800 °C. The YBCO and Au electrodes are 350 nm thick and 2.5  $\mu$ m thick, respectively. Data are shown for the cooling and warming cycles and were taken at 1.0 MHz. The contact area was 400  $\mu$ m x 400  $\mu$ m.

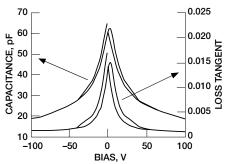


FIGURE 2 Capacitance and tanδ as a function of dc voltage for an interdigital Au/STO/LAO structure. The data were taken at 1.0 MHz.

interdigital fingers varied from 13 to 50, and the finger length was always 1.0 mm. Figure 2 shows the capacitance and tanδ of a Au/STO/LAO interdigital capacitor at 77 K and 1.0 MHz. Note that the degree of tuning and the tanδ values are larger and smaller, respectively, than those corresponding to parallel plate capacitors, although larger values of dc bias are required for the

interdigital configuration. For example, a tuning of 47% was attained at 80 K for the sample shown in figure 1 by applying a dc bias of just 5 V, while for the interdigital capacitor a tunability of 70% was observed at a dc voltage of 50 V. The loss behavior of the STO film in the interdigital structure was attributed to defects intrinsic to the STO whereas for the film in the parallel plate capacitor they were mainly dominated by electrical shorts of the YBCO through the STO film. Figure 3 shows the capacitance as a function of temperature and dc bias for Au/STO/LAO and Pt/BSTO/LAO (Ba:Sr;0.50:0.50) interdigital capacitors at 1.0 MHz. Observe that the point of maximum tuning

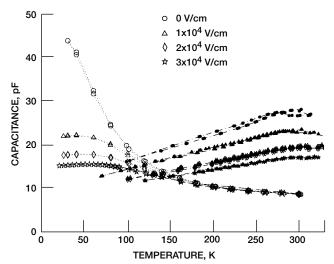


FIGURE 3 Capacitance versus temperature, for several electric field intensities, for a Au/STO/LAO interdigital capacitor (open symbols) and a Pt/BSTO/LAO interdigital capacitor (solid symbols). The data were taken at 1.0 MHz.

occurs at different temperatures. Therefore, applications at cryogenic temperatures could in principle be realized using STO films while those targeted for temperatures near or at room temperature could potentially be realized by using BSTO films.

Most of the studies on ferroelectric based structures heretofore have been performed at low frequencies. Table I shows a summary of some of these works, which provide data on  $\epsilon_r$ ,  $\tan\delta$ , type of structure, percent of tunability  $(((\epsilon_r(0) - \epsilon_r(V_{max}))/\epsilon_r(0)) \times 100 = (\Delta \epsilon_r/\epsilon_r(0)) \times 100)$ , and K-factor  $((\Delta \varepsilon_r/\varepsilon_r(0))/\tan \delta(0))$ , amongst others. The K-factor is a figure of merit that allows the comparison of different samples in a meaningful way. Therefore, as part of our study we have examined the performance of the (Au,HTS)/STO/LAO structures at K-band frequencies. Figure 4 shows a schematic diagram of a 25  $\Omega$  (with input/output 50 to 25  $\Omega$  transformers), and 50  $\Omega$  CMPS. For these phase shifters, the line capacitance was calculated by adapting the quasi-TEM variational expression of Koul and Bhat, [9] and using the transmission line method of Crampagne, Ahmadpanah, and Guiraud. [10] The coupled line structure was optimized to minimize loss and maximize phase shift. In doing so, we tried to capitalize in the fact that the thin ferroelectric film is most effective when the phase velocity (V<sub>n</sub>) is dominated by the odd mode fields. The propagation constant is given by,

$$\beta = \omega/V_p = (\pi/\lambda_o)[(\epsilon_{even})^{0.5} + (\epsilon_{odd})^{0.5}]$$
 (1)

where,  $\lambda_o$  is the free space wavelength,  $\epsilon_{even} = C_E/C_{Eair}$  and  $\epsilon_{odd} = C_O/C_{Oair}$ , and  $C_{Eair}$  and  $C_{Oair}$  are obtained by replacing all dielectrics with air. Thus, by capitalizing on the odd mode propagation constant, coupled microstripline phase shifters could yield more phase shift per

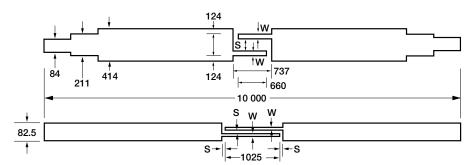


FIGURE 4 Au(1.5  $\mu$ m thick)/STO/LAO(254  $\mu$ m thick), microstrip transmission line with 20 GHz band-pass interdigital section (with input/output 50 to 25 Ohms transformers). S = 12.7  $\mu$ m, W = 76.2  $\mu$ m. Bottom; S = 7.5  $\mu$ m, W = 25  $\mu$ m. All dimensions are in microns.

TABLE I Ferroelectric based structures.

Reference	Babbitt, et al., Mic. Jour. 53, 1992	L.C. Sengupta et al., Army Science Conf., 1996	L.C. Sengupta et al., Army Science Conf., 1996	L.C. Sengupta et al., Army Science Conf., 1996	L.C. Sengupta et al., Army Science Conf., 1996	L.C. Sengupta et al., Army Science Conf., 1996	L.C. Sengupta et al., Army Science Conf., 1996	L.C. Sengupta et al., Army Science Conf., 1996	Boikov, et al., Supercon. Sci. Tech. 9, 1996	Boikov, et al., Supercon. Sci. Tech. 9, 1996	Boikov, et al., Supercon. Sci. Tech. 9, 1996
Volts	0	0 1.8	0 1.8	0 4	0 4	0	0	0	0	0.2	0
E (10 <sup>4</sup> V/cm)	0	3.0	3.0	0 10	0 10	0	0	0	0	9.9	0
Type of capacitor		parallel plate Pt/BSTO/ RuO <sub>2</sub>	parallel plate Pt/BSTO/ RuO <sub>2</sub>	parallel plate Pt/BSTO/ RuO <sub>2</sub>	parallel plate Pt/BSTO/ RuO <sub>2</sub>	parallel plate Pt/BSTO/ RuO <sub>2</sub>	parallel plate Pt/BSTO/ RuO <sub>2</sub>	parallel plate Pt/BSTO/ RuO <sub>2</sub>	parallel plate	parallel plate	parallel plate
K factor				15.9	18					13.9	
% tunability		23	22	20.7	12.7					8.6	
frequency, (GHz)	4.0	$0.5 \times 10^{-3}$	$0.5 \times 10^{-3}$	$0.5 \times 10^{-3}$	$0.5 \times 10^{-3}$	2.139	1.815	4.581	1×10 <sup>-4</sup>	1×10 <sup>-4</sup>	1×10 <sup>-4</sup>
tanδ	60'0			0.013	0.007	0.0040	0.0042	0.0065	0.01	700.0	0.018
ئ ع	008	1200 924	926 722	450 357	386 337	646	404	113	270	410 370	270 400 max.
Temp. (K)	298	298	298	298	298	298	298	298	298	LL	298 54
Electrode		Pt, RuO <sub>2</sub>	Pt, RuO <sub>2</sub>	Pt, RuO <sub>2</sub>	Pt, RuO <sub>2</sub>	Pt, RuO <sub>2</sub>	Pt, RuO <sub>2</sub>	Pt, RuO <sub>2</sub>	Ag/YBCO	Ag/YBCO	Ag/YBCO
Material	BSTO 0.45:0.55 Ceramic 508 µm thick	BSTO 0.6:0.4, PLD films, 0.6 μm thick	BSTO 0.6:0.4, PLD films, 0.6 μm, Oxide III doped	BSTO 0.6:0.4, MOD films, 0.4 µm thick	BSTO 0.6:0.4, MOD films, 0.4 μm thick, Oxide III doped	BSTO 0.6:0.4, Polycrystalline Pt, RuO <sub>2</sub> ceramic, 30% oxide III	BSTO 0.6:0.4, Polycrystalline ceramic 40% Oxide III	BSTO 0.6:0.4, Polycrystalline Pt, RuO <sub>2</sub> ceramic 60%	KTO, 0.3 μm thick, PLD films	KTO, 0.3 µm thick, PLD films	STO, 0.3 µm thick, PLD films

TABLE I Concluded.

Material	Electrode	Temp.	$\omega^{\scriptscriptstyle \perp}$	tanδ	frequency,	% tunability	K factor	Type of	E (10 <sup>4</sup> V/cm)	Volts	Reference
BSTO 0.25:0.75,3 µm thick, PLD films	YBCO	298 130	300 350 max	0.019	1×10 <sup>-4</sup>	,		1	0	0	Boikov, et al., Supercon. Sci. Tech. 9, 1996
BSTP, 0.1:0.9, pellet, 0.71 mm thick	YBCO	98	30,000	0.026	1×10 <sup>-4</sup>	83	31.9	coplanar slot capacitor	0 2.5	0 200	H-D Wu, et al. IEEE Trans. Appl. Sup. 4, 1994
BSTO, 0.08:0.92, 0.3 µm thick, MOD films	YBCO (PLD)	70	258 200	0.029	1×10 <sup>-4</sup>	22.5	7.8	Interdig. BSTO/YB	0	0 50	H-D Wu, et al. IEEE Trans. Appl. Sup. 4, 1994
STO, 2.0 μm thick, PLD films	YBCO	298 30 10	300		1×10-5			CO/LAO CPW, YBCO/STO/ LAO	0	0	Findikoglu et al., 1996 ASC
BSTO 0.6:0.4, 0.3 µm thick, PLD films	Pt, RuO <sub>2</sub>	298	1260 970		1×10-3	23		parallel plate capacitor (Al <sub>2</sub> O <sub>3</sub> is the substrate)	3.0	0.9	S. Sengupta, et al., ARL-TR-754 1995
BSTO 0.6:0.4, 0.3 µm thick, PLD films, 1% Oxide III	Pt, RuO <sub>2</sub>	298	735 559		1×10 <sup>-3</sup>	24		Parallel plate capacitor	3.0	0.9	S. Sengupta, et al., ARL-TR-754 1995
BSTO 0.6:0.4, pellet, 1 mm thick	Pt	298	3,300 2,640		1×10 <sup>-3</sup>	20		Parallel plate capacitor	0.73	730	S. Sengupta, et al., ARL-TR-754 1995
BSTO 0.6:0.4, 1 mm thick pellets, 1% Oxide III	Pt	298	1,276 1,072		1×10 <sup>-3</sup>	16		Parallel plate capacitor	0 2.32	0 2,320	S. Sengupta, et al., ARL-TR-754 1995
STO, 0.8 µm thick, PLD films	YBCO	77	1,150	0.1	1.2×10 <sup>-7</sup>	74	7.4	Parallel plate capacitor	0 10	0 8	Findikoglu et al., Appl. Phys. Lett. 63, 1993
STO, 550 nm thick, PLD film	YBCO	4	920 330	0.05	11	<del>7</del> 9	12.8	coplanar capacitor	8	0 40	D. Galt, et al., Appl. Phys. Lett., 63, 1993
BSTO, 0.6:0.4, 112 µm thick, tape casting	Au/Pd/Pt	298	3,192.2	0.0056	1×10 <sup>-6</sup>	43.52		coplanar capacitor	2.0	224	L.C. Sengupta, et al. ARL-TR-753, 1995

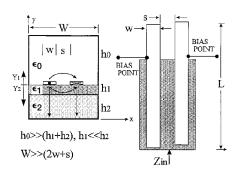


FIGURE 5 Coupled microstripline ferroelectric phase shifter.

unit length than simple microstrip lines while avoiding the need for a coplanar ground. The schematic shown in figure 5 summarizes our design approach.

Figure 6 shows experimental data, measured at 77 K and 19.4 GHz, for Au/STO(300 nm)/LAO and YBCO/STO(300 nm)/LAO CMPS. Note that a relative insertion phase shift ( $\Delta \phi$ ) of ~13° is

attained with a dc bias of 32 V ( $2.5\times10^4$  V/cm). By replacing the Au layer with a YBCO film, we obtained  $\Delta\phi\sim34^{\circ}$  at the same temperature, frequency and field. The raw insertion loss was less than 3 dB. Since the coupling length of the CMPS is 0.66 mm, this result implies that at 19 GHz and 32 V, a 360° phase shift could in principle be achieved with coupled microstripline sections only 7.0 mm long. Since this configuration relies in the odd mode propagation of the field across the ferroelectric film, we decided to investigate  $\Delta\phi$  for thicker STO films. Figure 7 shows  $\Delta\phi$  versus dc bias for Au/STO/LAO CMPS with 500 nm and 1.0  $\mu$ m thick STO films. Note that for both samples there is a reversal of  $\Delta\phi$  at a specific bias. This phase reversal can be explained in terms of change in  $\epsilon_r$  with applied field. By modeling the structure using Sonnet em®

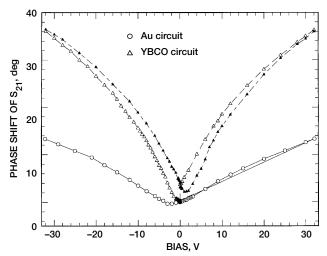


FIGURE 6 Au(1.5  $\mu$ m)/STO(300nm)/LAO(254  $\mu$ m) and YBCO(350 nm)/STO(300 nm)/LAO(254  $\mu$ m) 25  $\Omega$  coupled microstripline phase shifters. Open (solid) symbols denote increasing (decreasing) bias. The data were taken at 19.4 GHz.

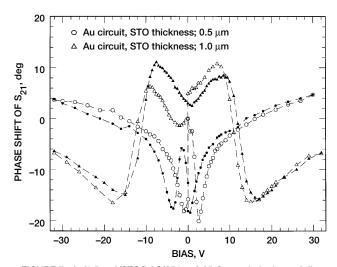


FIGURE 7 Au(1.5  $\mu$ m)/STO/LAO(254  $\mu$ m) 25  $\Omega$  coupled microstripline phase shifters. Open (solid) symbols denote increasing (decreasing) bias. The data were taken at 20.455 GHz.

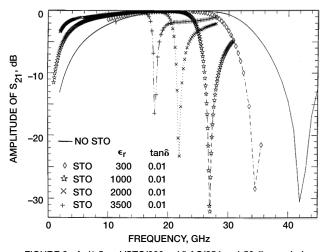


FIGURE 8 Au(1.5  $\mu m)/STO(300nm)/LAO(254~\mu m)$  50  $\Omega$  coupled microstripline phase shifters: Sonnet em® simulation.

simulator, one can see that the bandpass of the CMPS is very broad in the absence of STO (see figure 8). Adding the STO layer ( $\epsilon_r$  = 300) to the structure, results in a narrowing of the passband, which compresses even more as the structure is cooled to cryogenic temperatures and  $\epsilon_r$  for the STO layer increases ( $\epsilon_r$  ~ 3500). Applying the dc bias results in lower values of  $\epsilon_r$  with the concomitant shifting of the band edge to higher frequencies. Thus, the observed  $\Delta \varphi$  reversal for the 500 nm and 1.0  $\mu$ m films, results from the frequency of operation being at the band

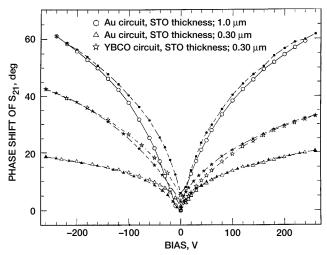


FIGURE 9 25  $\Omega$  coupled microstripline phase shifters; T = 77K, frequency = 13.73 GHz. Open (solid) symbols denote increasing (decreasing) bias.

edge of the CMPS passband for a given bias value within the bias range considered in this study. Hence, for the CMPS under consideration one must be careful to operate within the passband, or at frequencies where the passband is insensitive to changes in  $\varepsilon_r$ ; figure 8 suggests that frequencies near 14 GHz could satisfy this criteria. Figure 9 shows data taken at 77 K and 13.73 GHz for Au/STO/LAO CMPS with STO films 300 nm and 1.0  $\mu$ m thick, respectively. Note that for  $|V_{dc}| \le 260 \text{ V}$ ,  $\Delta \phi$ increases monotonically without any reversal. Also for the 1.0 µm film structure,  $\Delta \phi$  is nearly three times larger than that measured for the structure with the 300 nm thick STO film. Thus, for the temperature, frequency, and bias stated above, a 360° CMPS with a 1.0 µm thick STO film could be nominally 4.0 mm long, and with a 300 nm thick STO the same CMPS would be nominally 12 mm long. These estimates assume that the passband would be maintained over the operating range. The experimental results obtained here are within less than a factor of two of the values for  $\Delta \phi$  expected from theoretical predictions (see Table II).

TABLE II Theoretical insertion phase for coupled microstripline. (w = 76.2  $\mu$ m, s = 12.7  $\mu$ m) [Frequency = 13.0 GHz, L = 660  $\mu$ m.]

$\epsilon_{\text{STO}}$	$\Delta \phi(t_{STO} = 0.3 \ \mu m) \ deg.$	$\Delta \phi(t_{STO} = 1.0 \ \mu m) \ deg.$
200		
300	0.6	1.3
2000	6.7	17.4
3500	10.5	22.3
5000	13.7	28.7

Table III compare our results with those of others. Figure 9 also shows that, once again, replacing the Au film by the YBCO film resulted in larger  $\Delta\varphi$  values; this is presumably because of modified current distribution although more detailed analysis is required to fully account for this empirical behavior. As an additional advantage, tan $\delta$  does not seems to be a significant hindrance for the implementation of these phase shifters at K-band frequencies. Modeling of these structures by allowing tan $\delta$  of the substrate (i.e., STO and LAO as a whole) to be as high a 0.1, resulted in an insertion loss of less than 5 dB at 20 GHz and 77 K. For 700 nm thick BSTO (Ba:Sr; 0.4:0.6) thin films, the 25 $\Omega$  Au/BSTO/LAO CMPS showed  $\Delta\varphi\sim8^\circ$  -  $10^\circ$  at 296 and 200 K, respectively, for  $|V_{dc}|$  up to 160 V. The marginal performance suggests that further optimization of this material is required.

We have also investigated the performance of contiguous and interdigital ring resonators fabricated using Au/STO/LAO and YBCO/STO/LAO, respectively (figure 10). These resonators are intended for use in tunable discriminator-locked oscillators which could enhance the performance of LO for satellite communication systems, particularly by reducing the phase noise and consequently bit error rate (BER) degradation. [11,12] Figure 11 shows the magnitude of the transmission (S<sub>21</sub>) and reflection (S<sub>11</sub>) scattering parameters for Au/LAO and Au/STO/LAO ring resonators designed for operation at 20 GHz and with dimensions as given in figure 10. Observe that, as expected, there is slight shift in frequency (~2%) and a small increase (decrease) in insertion (return) loss due to the slight impedance change and loss tangent introduced by the STO layer. Figure 12 shows S<sub>21</sub> versus temperature

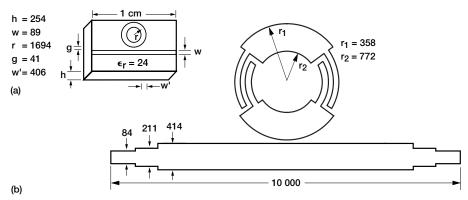


FIGURE 10 Au(1.5 μm thick)/STO (300 nm thick)/LAO (254 μm thick), 20 GHz ring resonators, (a) 25 Ohm ring, 50 Ohm transmission line, (b) 25 Ohm ring with interdigital gaps and input/output 50 to 25 Ohms transformer. All dimensions are in microns.

TABLE III Ferroelectric based phase shifters.

Reference			Babbitt, et al., Mic. Jour. 53, 1992	L.C. Sengupta et al., Army Science Conf. 1996	Findikoglu, et al., Micro. Opt. Tech. Lett., 9, 1995	Findikoglu, et al., ACS 1996			Findikoglu, et al., ACS 1996	Findikoglu, et al., ACS 1996	Findikoglu, et al., ACS 1996	Gevorgian, et al., ACS 96	Miranda, et al., (This Conference)	Miranda, et al. (This Conference)
Voltage (V)			610	20	40	5	5	5	10	10	10	35	32	32
E (10 <sup>4</sup> V/cm)			1.2	1	1.0	0.25	0.25	0.25	0.50	0.50	0.50	1.4	2.5	2.5
Return	(dB)		15	-										
Insertion	(dB)		2.5 over a 20% band width	10		<3 dB	<3 dB	<3 dB	<3 dB	<3 dB	<3 dB	~2.5		<2.2
Phase shift		(Deg/mm)	5.3		2.5	0.44	0.88	13.3	0.88	1.78	2.67	10	19.7	51.5
Pha		(Deg.)	35	47	15	~100	~200	~300	~200	~400	009~	~40	13	34
F (GHz)			4.0	35	2	1	2	3	1	2	3	20	19.4	18.305
T (K)			867	867	LL	92	92	92	92	92	92	09	LL	LL
Structure			Metal/Duroid $\varepsilon_r = 2.2$ ) & metal/ferroelectric (rod type) microstrip phase shifter, $L = 6.550 \text{ mm}$	CPW, with 0.5 μm metallization	CPW (YBCO (0.4 μm)/ STO/LAO (500 μm), L = 6.0 mm	YBCO Meander line CPW L = 25 cm; area: $1 \times 1$ cm (YBCO)						CPW YBCO (300 nm)/ BSTO/LAO L = 4 mm	Interdigital Coupled lines AU (1.5 $\mu$ m)/STO/LAO (254 $\mu$ m), L = 0.66 mm	Interdigial Coupled lines YBCO (35 µm)/STO/ LAO (254 µm), L = 0.66 mm
Material			BSTO (0.45:0.55), ceramic, 508 μ m thick	BSTO (0.6:0.4), 1.0 μm thick film on sapphire	STO, 2 μm thick film, PLD	STP, 1.0 μm thick film, PLD						BSTO (5% Ba), 960 nm thick film, PLD	STO, 300 nm thick film, PLD	STO, 300 nm thick film, PLD

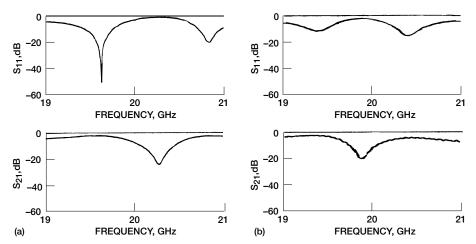


FIGURE 11 Transmission ( $S_{21}$ ) and reflection ( $S_{11}$ ) scattering parameters for (a) Au(1.5  $\mu$ m)/LAO (254  $\mu$ m) and (b) Au(1.5  $\mu$ m)/STO(300 nm)/LAO(254  $\mu$ m) 25 Ohm ring resonators at room temperature. The power level was 10 dBm.  $\Delta$ F = 2%, F = resonant frequency.

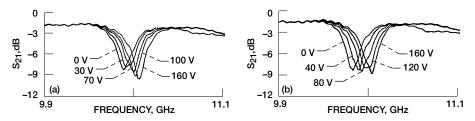


FIGURE 12 YBCO (350 nm)/STO (300 nm)/LAO (254  $\mu$ m) 25  $\Omega$ , 2  $\lambda$  ring resonators; (a) 77 K, (b) 50 K.

for a YBCO/STO(300 nm)/LAO 25  $\Omega$ ,  $2\lambda$ , interdigital ring resonator at 10 GHz. At 77 K, the resonant frequency of the resonator shifted by 110 MHz with a 160 V dc bias; at 50 K, the frequency shift was ~160 MHz. This resonator exhibited loaded and unloaded Q's of 54 and 110, respectively, at no bias, and of 55 and 160 at 160 V, as calculated using the method of Khanna and Garault. [13]

### **CONCLUSIONS**

We have reported on the characterization of (metal, HTS)/STO/YBCO and (metal)/BSTO/LAO thin film multilayer structures in terms of the dielectric properties of the ferroelectric layer at frequencies up to 20 GHz. We have observed that the largest tuning of the Au/STO/YBCO parallel plate capacitors corresponds to single-phased, epitaxial

300-500 nm thick STO films deposited at 800 °C. Although the STO films in parallel plate configuration can be tuned with low dc bias (0-5 V), their performance is limited by the high effective tan  $\delta$ . Higher dc voltages (tens of volts) are required to tune the interdigital structures, but their higher degree of tunability and lower tanδ make them attractive for microwave applications. We have developed proof-of-concept coupled microstrip lines phase shifters at 20 GHz, with low insertion loss and promising insertion phase shift per unit length. Implementation of these phase shifters with YBCO microstriplines resulted in greater phase shift per unit length than their metallic counterparts, presumably because of modified current distribution. These phase shifters are competitive with solid state-switched phase shifters in terms of performance and size, and promise simplicity of fabrication and cost advantage. For 2λ YBCO/STO ring resonators, unloaded Q's improved with bias and showed values of 110 and 160 at zero and 160 V, respectively. For this resonator a tuning rate of ~0.7 MHz/Volt was achieved at 77 K and 10 GHz. This type of ring resonator can be incorporated as a tunable element in a discriminator-locked oscillator. Optimization of this configuration and ring resonator configurations is currently underway.

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High Temperature Superconductors are currently being investigated tions. The main goal for this tects of as to avoid performance degromponents. Therefore, for HTS the material and electrical proper aspects such as the appropriate the should be carefully considered. The nent is are also dependent on the addition, the performance of the paper, we will present our result BaxSr <sub>1-x</sub> TiO <sub>3</sub> /YBa <sub>2</sub> Cu <sub>3</sub> O <sub>7-8</sub> /Late variation of the dielectric constates The largest tuning of the STO/Y with a thickness of 500 nm. High temperatures resulted in films we structures having STO film of situnabilities and lower losses that geometries in working microwarcussed.	for use in low loss, tunable michnology is to achieve maximum adation when replacing convented. TE components to be successfurties of the ferroelectric films, type of ferroelectric and optimically the tunability range as well as geometry chosen (e.g., parallel ecircuit is dependent on the local action to the study of the SrTiO <sub>3</sub> /Y aAlO <sub>3</sub> (BSTO/YBCO/LAO) HT and upon the application of a defect the temperatures resulted in intentity in the constants, imilar quality we have observed in parallel plate configurations,	crowave components for some tunability while keeping tional technology (e.g., first ully integrated into current without degrading those of the technology cation of the deposition of the microwave losses of plate capacitor, interdigitation of the varactor in the Ba <sub>2</sub> Cu <sub>3</sub> O <sub>7-8</sub> /LaAlO <sub>3</sub> (ST) (ST) E multilayered structure electric field is closely rended to single-phased, epierfacial degradation and lower tunabilities, and high that interdigital capacito but required higher de vo	satellite and ground based communicage the microwave losses as low as possible alters and oscillators) with HTS/FE int working systems, full optimization of the HTS film, is required. Hence, conditions (e.g., deposition temperature) the desired varactor (i.e., tunable compotal capacitor, coplanar waveguide, etc.). In the circuit and the biasing circuitry. In this TO/YBCO/LAO) and the tures. We have observed that the amount of elated to the microstructure of the film. itaxial STO films deposited at 800° C and poor film quality, while lower deposition gher losses. For STO/LAO multilayer or configurations allow for higher obtage. Results on the use of these for local oscillators (LO) will be dis-
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